













JMP® 14 Quick Guide

Instructions presume an open data table, default preference settings, and appropriately typed, user-specified variables of interest.





Graphing

What	How
Frequency Distribution	Analyze > Distribution (For categorical variables frequencies are displayed, otherwise quantiles and summary statistics are)
Bar Chart	Graph > Graph Builder > drag continuous variable to Y and categorical to X > click bar icon Or: Graph > Legacy > Chart
Pie Chart	Graph > Graph Builder > drag continuous variable to Y and categorical to X > click pie icon Or: Graph > Legacy > Chart > Options > Pie Chart
Histogram	Analyze > Distribution Or: Graph > Graph Builder > drag variable to Y or to X > click histogram icon
Stem and Leaf Plot	Analyze > Distribution; select lower  Stem and Leaf
Scatter Plot 2-D	Graph > Graph Builder > drag continuous variable to Y and another one to X Or: Analyze > Fit Y by X (Bivariate) Or: Graph > Overlay Plot
Scatter Plot 3-D	Graph > Scatterplot 3-D
Scatter Plot Matrix	Graph > Scatterplot Matrix Or: Analyze > Multivariate Methods > Multivariate
Trellis Plot	Graph > Graph Builder > drag one column to Y and one to X; drag nominal or ordinal column to Wrap
Line Chart	Graph > Graph Builder > drag continuous variable to Y and another one (time ordered) to X > click line icon Or: Graph > Overlay Plot; select  Y options > Connect Thru Missing
Box Plot - One Level	Graph > Graph Builder > continuous column to Y > click box plot icon Or: Analyze > Distribution
Box Plot - Two or More Levels	Graph > Graph Builder > continuous column to Y and categorical to X > click box plot icon Or: Analyze > Fit Y by X (choose continuous Y and categorical X); select  Display Options > Box Plot
Geospatial Mapping	Graph > Graph Builder > drag a column containing city, county, state, or country to the Map Shape zone (bottom left) Or: Use latitude and longitude as X and Y, right-click center and pick Graph > Background Map to choose map




Basic Statistics

What	How
Descriptive Statistics	Analyze > Distribution; (basic stats are shown by default; to see more select lower  Display Options > Customize Summary Statistics) Or: Analyze > Tabulate Or: Tables > Summary Or: Cols > Columns Viewer; select columns then click Show Summary
z- or t- test with confidence intervals	1-Sample: Analyze > Distribution; select lower  Test Mean 2-Sample: Analyze > Fit Y by X (cont. Y and 2-level cat. X); select  t Test or Means/ANOVA/Pooled t Paired t: Analyze > Specialized Modeling > Matched Pairs
Testing Proportions (<i>make 0/1 indicator Nominal or Ordinal</i>)	1 Proportion: Analyze > Distribution; select lower  Test Probabilities 2 Proportions: Analyze > Fit Y by X
Contingency Table – Chi-Square Test	Analyze > Fit Y by X (both X and Y must be categorical, and labels must be in columns)
Covariance	Analyze > Multivariate Methods > Multivariate; select  Covariance matrix
Correlation	Analyze > Multivariate Methods > Multivariate Or: Analyze > Fit Y by X > Density Ellipse
Test for Normality/Goodness-of-Fit	Analyze > Distribution; select  continuous Fit > Normal; select  by Fitted Normal > Goodness of Fit
Sample Size and Power Calculations	DOE > Design Diagnostics > Sample Size and Power







Probability and Random Variables

What	How
Probability Variables	On data table: 1. Select  Columns > New Column; 2. Right click on new column > Formula; 3. Select Probability from Functions Window; 4. Select desired probability function.
<i>Note: For more information on the expected parameters see Help under Probability Functions.</i>	
Random Variables	On data table: 1. Select  Columns > New Column; 2. Right click on new column; 3. Select New Formula Column > Random; 4. Select desired Random function
	or On data table: 1. Select  Columns > New Column; 2. Right click on new column; 3. Select Formula; 4. Select Random from Functions Window; 5. Select desired Random function.
<i>Note: For more information on the expected parameters see Help under Random Functions.</i>	
Distribution Fitting	Analyze > Distribution; select lower  continuous Fit or Discrete Fit, then select desired distribution(s).





Analysis of Variance

What	How
One-Way	Analyze > Fit Y by X; select  Means/Anova (Y must be continuous; X categorical)
Two or More Factors	Analyze > Fit Model
Randomized Blocks	Analyze > Fit Y by X; include a categorical column in Block role
Multiple Comparison Methods	Analyze > Fit Y by X; select  Compare Means
Test for Unequal Variances	Analyze > Fit Y by X; select  Unequal Variances




Regression

What	How
Scatterplot	Analyze > Fit Y by X (Bivariate) Or: Graph > Graph Builder > drag continuous column to Y and another to X
Ordinary Least Squares	One Predictor: Analyze > Fit continuous Y by continuous X; select  Fit Line Or: click line icon from Scatterplot in Graph Builder (see above). One or More Predictors: Analyze > Fit Model
Logistic Regression	One Predictor: Analyze > Fit categorical Y by continuous X One or more Predictors: Analyze > Fit Model
Multiple Regression	Analyze > Fit Model
Stepwise Regression	Analyze > Fit Model > Personality; select Stepwise
Residual Analysis	Analyze > Fit Model; Run Model; select  Row Diagnostics Or: Analyze > Fit Y by X; select  and choose a fit; select  from fit report and “Save Residuals” or “Plot residuals”
Interaction Plots	Analyze > Fit Model with interaction effects; Run Model; select  Factor Profiling > Interaction Plots
Durbin-Watson Test	Analyze > Fit Model; Run; select  Row Diagnostics > Durbin-Watson Test





Nonparametric Techniques

What	How
Wilcoxon Rank Sum Test	Analyze > Fit Y by X (Continuous Y by Categorical X); select  Nonparametric > Wilcoxon Test
Fisher's Sign Test (for 2x2 tables only)	Analyze > Fit Y by X (categorical by categorical)
Wilcoxon Signed Rank Sum Test	Analyze > Distribution on continuous X; select lower  Test Mean > check Wilcoxon Signed Rank Box
Kruskal-Wallis Test	Analyze > Fit Y by X (continuous by categorical); select  Nonparametric > Wilcoxon Signed Rank Test
Spearman's ρ	Analyze > Multivariate Methods > Multivariate; select  Nonparametric Correlations > Spearman's ρ


Time Series

What	How
Time Series Plot	Analyze > Specialized Modeling > Time Series
Moving Averages	Analyze > Specialized Modeling > Time Series; select  Smoothing Models > Simple Moving Average
Exponential Smoothing	Analyze > Specialized Modeling > Time Series; select  Smoothing Models > Choose Method
Holt-Winters (Additive) Method	Analyze > Specialized Modeling > Time Series; select  Smoothing Model > Winters Method

Advanced Modeling and Multivariate Methods

What	How
Logistic and Multiple Regression	Analyze > Fit Model
Clustering	Analyze > Clustering > Choose Method
Neural Networks	Analyze > Predictive Modeling > Neural
Decision Trees	Analyze > Predictive Modeling > Partition
Factor Analysis	Analyze > Consumer Research > Multiple Factor Analysis
Principal Component Analysis	Analyze > Multivariate Methods > Principal Component
Multiple Correspondence Analysis	Analyze > Consumer Research > Multiple Correspondence Analysis
Partial Least Squares	Analyze > Multivariate Methods > Partial Least Squares Or: Analyze > Fit Model > Personality; select Partial Least Squares
 Model Comparison	Analyze > Predictive Modeling > Model Comparison Or: Analyze > Predictive Modeling > Formula Depot; select  Model Comparison
 Generalized Regression	Analyze > Fit Model > Personality; select Generalized Regression
 Mixed Models	Analyze > Fit Model > Personality; select Mixed Model

Quality Control

What	How
Control Charts	Run Chart: *Analyze > Quality and Process > Control Chart > Run Chart X-Bar R or S: *Analyze > Quality and Process > Control Chart > Control Chart > X-Bar Individual Measurements (IR): *Analyze > Quality and Process > Control Chart > Control Chart > IR P, NP, C or U Chart: *Analyze > Quality and Process > Control Chart > Control Chart > P, NP, C or U UWMA Chart: Analyze > Quality and Process > Control Chart > Control Chart > UWMA EWMA Chart: Analyze > Quality and Process > Control Chart > Control Chart > EWMA CUSUM: Analyze > Quality and Process > Control Chart > Control Chart > CUSUM G Chart: Analyze > Quality and Process > Control Chart Builder, select Rare Event T Chart: Analyze > Quality and Process > Control Chart Builder, select Rare Event, change sigma limits to Weibull
	* Can also be created with the Control Chart Builder: Analyze > Quality and Process > Control Chart Builder
Pareto	Analyze > Quality and Process > Pareto Plot
Ishikawa (“Fishbone”) Diagram	Analyze > Quality and Process > Diagram
Variability Chart (Multi-Vari Chart)	Analyze > Quality and Process > Variability / Attribute Gauge Chart
Capability	One Variable: Analyze > Distribution, select lower  Capability Analysis More than One Variable: Analyze > Quality and Process > Process Capability With additional graphs on same output: Analyze > Quality and Process > Control Chart > IR or X-Bar Chart; check Capability Box > OK
Measurement Systems Analysis	Analyze > Quality and Process > Measurement Systems Analysis Or: Analyze > Quality and Process > Variability / Attribute Gauge Chart

Design of Experiments (DOE)

What	How
Custom Design (optimal designs)	DOE > Custom Design
Factorial Design	DOE > Classical > Full Factorial Design Or: DOE > Classical > Screening Design
Screening Design	DOE > Classical > Screening Design
Response Surface Design	DOE > Classical > Response Surface Design

Other designs are also available under the DOE menu.

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For complete information and tutorials, please refer to the JMP Help available under “Help > Books” and “Help > Tutorials.”

For one-page guides, videos and additional tutorials, see the Learning Library at **jmp.com/learn**.



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